

Description

The SM3012T9RL uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.



TO-252-4L

General Features

 $V_{DS} = 30V I_{D} = 20A$

 $R_{DS(ON)}$ < 22m Ω @ V_{GS} =10V

 $V_{DS} = -30V I_{D} = -23A$

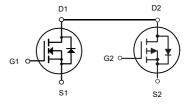
 $R_{DS(ON)}$ < 30 m Ω @ V_{GS} =-10V

Application

Wireless charging

Boost driver

Brushless motor



N-Channel MOSFET

P-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
SM3012T9RL	TO-252-4L	HXY MOSFET	2500

Absolute Maximum Ratings (T_C=25 ℃ unless otherwise noted)

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Symbol	Parameter	N-Channel	P-Channel	Units	
VDS	Drain-Source Voltage	30	-30	V	
VGS	Gate-Source Voltage	±20	±20	V	
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	20	-23	А	
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	15	-14	А	
IDM	Pulsed Drain Current ²	60	-60	А	
EAS	Single Pulse Avalanche Energy ³	26.6	38	mJ	
P _D @T _A =25℃	Total Power Dissipation ⁴	20.8	20.8	W	
TSTG	Storage Temperature Range	-55 to 150	-55 to 150	$^{\circ}$	
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	$^{\circ}$	
R _θ JA	Thermal Resistance Junction-Ambient ¹	62		°C/W	
R _θ JC	Thermal Resistance Junction-Case ¹	6		°C/W	



N-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
△BV _{DSS} /△T	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.023		V/°C
Б	Static Projectory On Registery 2	V _{GS} =10V , I _D =10A		18	22	0
R _{DS(ON)}	$R_{DS(ON)}$ Static Drain-Source On-Resistance ² V_{GS} =4.5V , I_D =6A		20	25	mΩ	
V _{GS(th)}	Gate Threshold Voltage	\\ -\\ \ \ \ -250\	1.0		2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-4.2		mV/°C
	Desir Course Lockers Course	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	· uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 20V$, $V_{DS} = 0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =10A		14		S
R _g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.3		Ω
Qg	Total Gate Charge (4.5V)			5		
Q _{gs}	Gate-Source Charge	V _{DS} =20V , V _{GS} =4.5V , I _D =10A		1.11		nC
Q_{gd}	Gate-Drain Charge			2.61		
T _{d(on)}	Turn-On Delay Time			7.7		
Tr	Rise Time	V_{DD} =12V , V_{GS} =10V , R_{G} =3.3 Ω		46		
T _{d(off)}	Turn-Off Delay Time	I _D =6A		11		ns
T _f	Fall Time			3.6		
C _{iss}	Input Capacitance			416		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		62		pF
Crss	Reverse Transfer Capacitance			51		
Is	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			20	А
I _{SM}	Pulsed Source Current ^{2,5}	vg-vp-ov , i oroc ourrent			40	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V

^{1.} The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

^{2.}The data tested by pulsed , pulse width $\leq 300 \text{us}$, duty cycle $\leq 2\%$

^{3.} The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=12.7A 4. The power dissipation is limited by 150°C junction temperature

^{5.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



P-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I_D =-250uA	-30			V
△BV _{DSS} /△T	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.021		V/°C
В	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-8A		25	30	mΩ
MDS(ON)	$R_{DS(ON)}$ Static Drain-Source On-Resistance ² V_{GS} =-4.5V , I_D =-6A	V _{GS} =-4.5V , I _D =-6A		30	35	
V _{GS(th)}	Gate Threshold Voltage	\/ -\/ - 250A	-1.0		-2.5	V
$\Delta V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=-250uA$		-4.2		mV/°C
	Drain Source Leekage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			1	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =55°C			5	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 20V$, $V_{DS} = 0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-8A		12.6		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		15		Ω
Qg	Total Gate Charge (-4.5V)			9.8		
Q_{gs}	Gate-Source Charge	V_{DS} =-20V , V_{GS} =-4.5V , I_{D} =-6A		2.2		nC
Q _{gd}	Gate-Drain Charge			3.4		
T _{d(on)}	Turn-On Delay Time			16.4		
Tr	Rise Time	V_{DD} =-24V , V_{GS} =-10V , R_{G} =3.3 Ω ,		20.2		na
T _{d(off)}	Turn-Off Delay Time	I _D =-1A		55		ns
Tf	Fall Time			10		
C _{iss}	Input Capacitance			930		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		148		pF
C _{rss}	Reverse Transfer Capacitance			115		
Is	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			-23	Α
I _{SM}	Pulsed Source Current ^{2,5}	vg-vb-ov , i oloc dundin			-35	Α
V_{SD}	Diode Forward Voltage ²	V_{GS} =0V , I_{S} =-1A , T_{J} =25 $^{\circ}$ C			-1.2	V

^{1.} The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper. 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

^{3.}The EAS data shows Max. rating . The test condition is V_{DD} =-25V, V_{GS} =-10V,L=0.1mH,I_{AS}=-30A 4.The power dissipation is limited by 150°C junction temperature

^{5.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



N-Channel Typical Characteristics

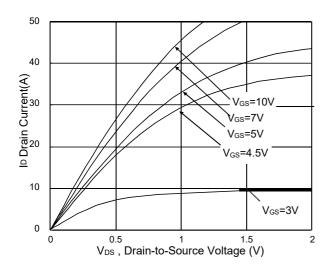


Fig.1 Typical Output Characteristics

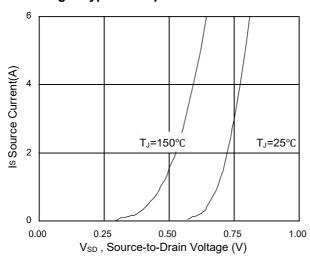


Fig.3 Forward Characteristics Of Reverse

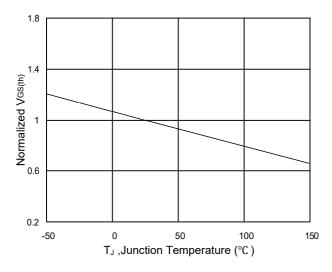


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

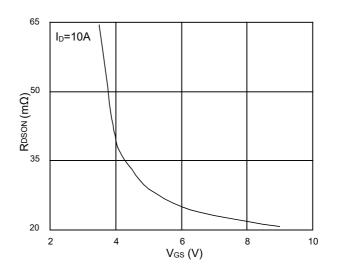


Fig.2 On-Resistance vs. Gate-Source

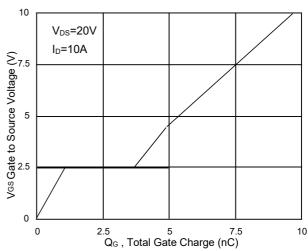


Fig.4 Gate-Charge Characteristics

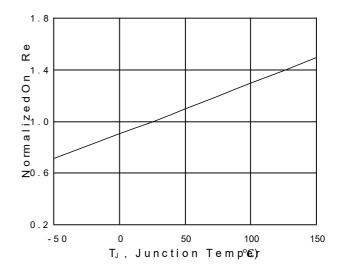
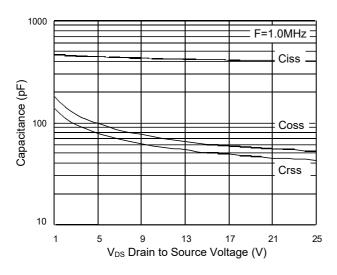


Fig.6 Normalized R_{DSON} vs. T_J





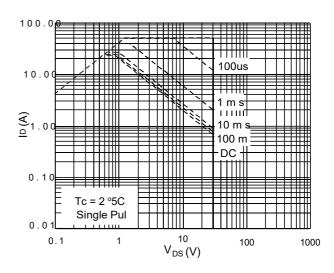


Fig.7 Capacitance

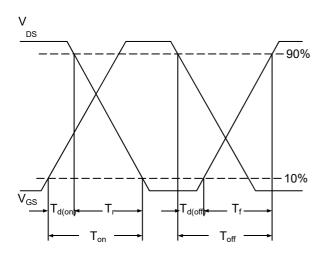
Fig.8 Safe Operating Area

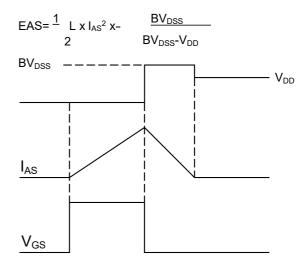
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DUTY=0.5

Town
Tupeak Tc+P_{DM}XR_{BJC}

Fig.9 Normalized Maximum Transient Thermal Impedance







P-Channel Typical Characteristics

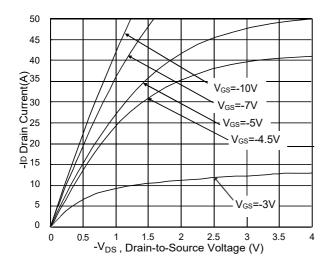


Fig.1 Typical Output Characteristics

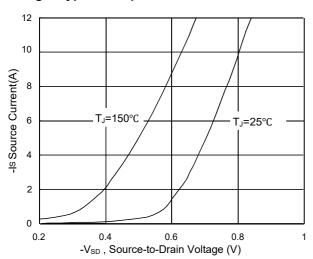


Fig.3 Forward Characteristics Of Reverse

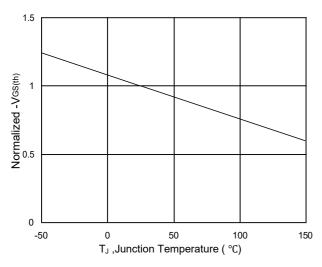


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

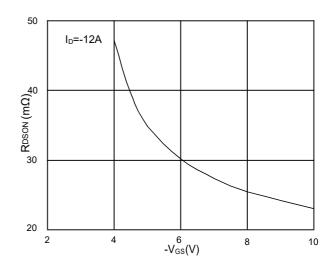


Fig.2 On-Resistance v.s Gate-Source

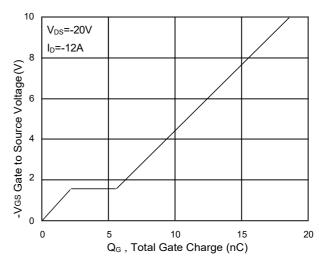


Fig.4 Gate-Charge Characteristics

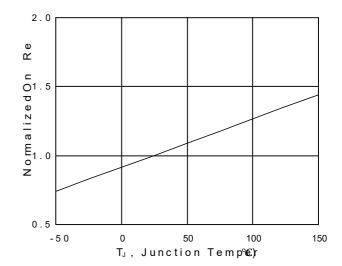
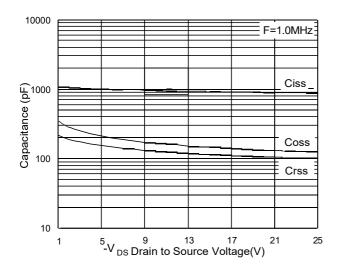


Fig.6 Normalized RDSON v.s TJ





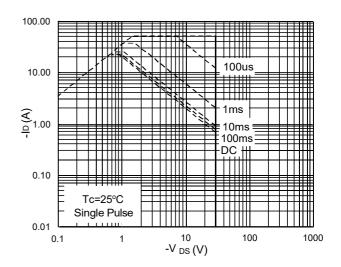


Fig.7 Capacitance

Fig.8 Safe Operating Area

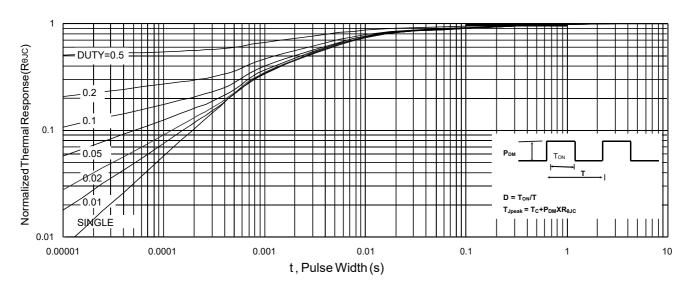


Fig.9 Normalized Maximum Transient Thermal Impedance

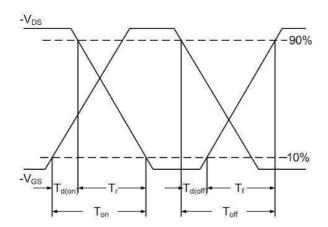


Fig.10 Switching Time Waveform

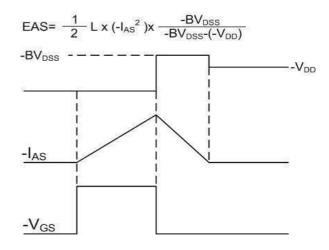
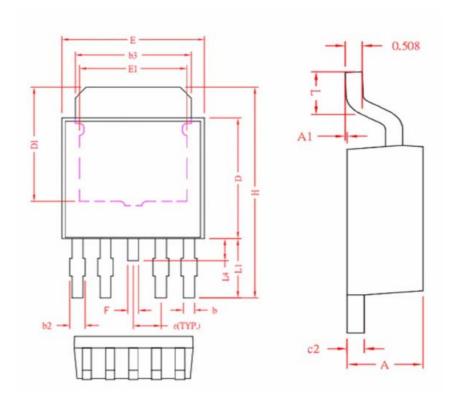


Fig.11 Unclamped Inductive Switching Waveform



TO-252-4L Package Information



COMMON DIMENSIONS

(UNII2	OF MEAS	UKE=MILI	IMETER,		
SYMBOL	MIN	NOM	MAX		
A	2.20	2.30	2.40		
A1	0	0.08	0.15		
b	0.45	0.53	0.60		
b2	0.50	0.65	0.80		
b3	5.20	5.35	5.50		
c2	0.45	0.50	0.55		
D	5.40	5. 60	5.80		
D1	4.57	-	-		
E	6.40	6.60	6.80		
E1	3.81	-	-		
е	1	1.27 REF.			
F	0.40	0.50	0.60		
Н	9.40	9.80	10.20		
L	1.40	1.59	1.77		
LI	2.40	2.70	3.00		
L4	0.80	1.00	1.20		



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